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| Notice of References Cited | Application/Control No. 10/521,912 | Applicant(s)/Patent Under Reexamination FAUR ET AL. | |
| | Examiner Freddie Kirkland III | Art Unit 2855 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-5,715,162 A | 02-1998 | Daigle, Jeffrey L. | 701/99 |
| * | B | US-2001/0002791 A1 | 06-2001 | Tsuge et al. | 324/174 |
| * | C | US-6,282,954 B1 | 09-2001 | Ott et al. | 73/488 |
| * | D | US-2002/0149275 A1 | 10-2002 | Gauthier et al. | 310/68.00B |
| * | E | US-6,492,804 B2 | 12-2002 | Tsuge et al. | 324/166 |
| * | F | US-6,508,116 B1 | 01-2003 | Adachi et al. | 73/170.02 |
| * | G | US-6,630,821 B2 | 10-2003 | Shinjo et al. | 324/207.21 |
| * | H | US-6,859,000 B2 | 02-2005 | Kessler et al. | 318/254 |
| * | I | US-6,881,507 B2 | 04-2005 | Milacic, Milos | 429/12 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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